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DAC53401, DAC43401

ZHCSK27A-JULY 2019-REVISED DECEMBER 2019

具有非易失性存储器和兼容 PMBus™ 的 I²C 接口、采用微型 2 × 2 WSON 封装的 DACx3401 10 位和 8 位电压输出数模转换器

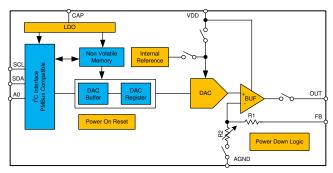
1 特性

- 1 LSB INL 和 DNL(10 位和 8 位)
- 宽工作范围
 - 电源电压: 1.8V 至 5.5V
 - 温度范围: -40℃至 +125℃
- 兼容 PMBus 的 ™I²C 接口
 - 标准、快速和快速+模式
 - 数字压摆率控制
 - 1.62V V_{IH} (V_{DD} = 5.5V)
- 用户可编程的非易失性存储器 (NVM/EEPROM)
 保存和撤销所有寄存器设置
- 产生的可编程波形:方形、斜坡和锯齿状
- 预编程医用警报音调生成模式:低、中和高优先级 警报
- 内部基准
- 超低功耗: 0.2mA (1.8V)
- 灵活启动:高阻抗或 10K 接地
- 微型封装: 8 引脚 WSON (2mm × 2mm)

2 应用

- 机架式服务器
- 出口和紧急照明
- 汽车类 USB 充电
- 条形码扫描仪
- 有源天线系统 mMIMO (AAS)
- CPU (PLC 控制器)

功能方框图



3 说明

10 位 DAC53401 和 8 位 DAC43401 (DACx3401) 是 具有引脚兼容性的缓冲电压输出数模转换器 (DAC) 系 列产品。这些器件功耗极低且均可采用微型 8 引脚 WSON 封装。凭借这组特性以及微型封装和低功 耗,DACx3401 非常适合以下 应用: LED 和通用偏置 点生成、电源控制、数字转换器、PWM 信号生成以及 医用警报音调生成。

这些器件具有非易失性存储器 (NVM)、一个内部基准 和一个兼容 PMBus 的 I²C 接口。DACx3401 在内部基 准或电源基准下运行,提供 1.8V 至 5.5V 的满量程输 出。该器件通过 I²C 接口通信。这些器件支持 I²C 标准 模式、快速模式和快速+模式。

DACx3401 具有多种特性,而且包括 PMBus 电压裕量 指令、具有高阻抗的用户可编程电源、独立波形发生 器、医用警报音调发生器和专用的反馈引脚等。

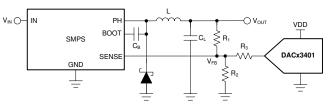
DACx3401 的工作温度范围为 -40℃ 至 +125℃。

器件信息⁽¹⁾

器件型号	封装	封装尺寸(标称值)
DAC53401		2.00mm 2.00mm
DAC43401	WSON (8)	2.00mm × 2.00mm

(1) 如需了解所有可用封装,请参阅数据表末尾的封装选项附录。

使用 DACx3401 的电源控制



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4 修订历史记录

Changes from Original (July 2019) to Revision A

• 己更改 将 DAC53401 和 DAC43401 器件从"预告信息(预发布)"更改为"生产数据(正在供货)" 1

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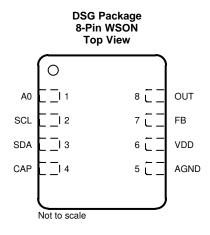
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5 Device Comparison Table

DEVICE	RESOLUTION
DAC53401	10-bit
DAC43401	8-bit

6 Pin Configuration and Functions



Pin Functions

PIN		TYPE	DESCRIPTION		
NAME	NO.	ITPE	DESCRIPTION		
A0	1	Input	Four-state address input		
AGND	5	Ground	Ground reference point for all circuitry on the device		
CAP	4	Input	External capacitor for the internal LDO. Connect a capacitor (0.5 μF to 15 $\mu F)$ between CAP and AGND.		
FB	7	Input	Voltage feedback pin		
OUT	8	Output	Analog output voltage from DAC		
SCL	2	Input	Serial interface clock. This pin must be connected to the supply voltage with an external pullup resistor.		
SDA	3	Input/output	Data are clocked into or out of the input register. This pin is a bidirectional, and must be connected to the supply voltage with an external pullup resistor.		
VDD	6	Power	Analog supply voltage: 1.8 V to 5.5 V		

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V _{DD}	Supply voltage, V _{DD} to A _{GND}	-0.3	6	V
	Digital input(s) to A _{GND}	-0.3	V _{DD} + 0.3	V
	CAP to A _{GND}	-0.3	1.65	
	V _{FB} to A _{GND}	-0.3	V _{DD} + 0.3	V
	V _{OUT} to A _{GND}	-0.3	V _{DD} + 0.3	
	Current into any pin	-10	10	mA
TJ	Junction temperature	-40	150	°C
T _{stg}	Storage temperature	-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, pins 1, 4, 5, $8^{(2)}$	±750	v
	alconargo	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾ ±2000 Static charged device model (CDM), per JEDEC specification JESD22-C101, pins 1.4.5.8 ⁽²⁾	±500	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _{DD}	Positive supply voltage to ground (A _{GND})	1.71		5.5	V
VIH	Digital input high voltage, 1.7 V < $V_{DD} \le 5.5$ V	1.62			V
V _{IL}	Digital input low voltage			0.4	V
T _A	Ambient temperature	-40		125	°C

7.4 Thermal Information

		DACx3401	
	THERMAL METRIC ⁽¹⁾	DSG (WSON)	UNIT
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	49	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	50	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	24.1	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	1.1	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	24.1	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	8.7	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



7.5 Electrical Characteristics

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.8 V $\leq V_{DD} \leq 5.5$ V, DAC reference tied to VDD, gain = 1x, DAC output pin (OUT) loaded with resistive load ($R_L = 5 \text{ k}\Omega$ to AGND) and capacitive load ($C_L = 200 \text{ pF}$ to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
STAT	IC PERFORMANCE						
	Desclution	DAC53401	10			Dite	
	Resolution	DAC43401	8			Bits	
INL	Relative accuracy ⁽¹⁾		-1		1	LSB	
DNL	Differential nonlinearity ⁽¹⁾		-1		1	LSB	
	7	Code 0d into DAC		6	12		
	Zero code error	Internal V _{REF} , gain = 4x, V_{DD} = 5.5 V		6	15	mV	
	Zero code error temperature coefficient			±10		µV/°C	
	Offset error ⁽¹⁾		-0.5	0.25	0.5	%FSR	
	Offset error temperature coefficient ⁽¹⁾			±0.0003		%FSR/°	
	Gain error ⁽¹⁾		-0.5	0.25	0.5	%FSR	
	Gain error temperature coefficient ⁽¹⁾			±0.0008		%FSR/°	
		$1.8 \text{ V} \leq \text{V}_{\text{DD}} \prec 2.7 \text{ V}$, code 1023d into DAC, no headroom	-1	0.5	1	0/ 500	
	Full scale error	$2.7 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}$, code 1023d into DAC, no headroom	-0.5	0.25	0.5	%FSR	
	Full scale error temperature coefficient			±0.0008		%FSR/°	
OUTF	PUT CHARACTERISTICS						
	Output voltage	Reference tied to V _{DD}	0		5.5	V	
^	Capacitive load ⁽²⁾	R_L = Infinite, phase margin = 30°			1	۳Ē	
CL		$R_L = 5 k\Omega$, phase margin = 30°			2	nF	
	Load regulation	DAC at midscale, -10 mA $\leq I_{OUT} \leq$ 10 mA, $V_{DD} = 5.5 \text{ V}$		0.4		mV/mA	
		V_{DD} = 1.8 V, full-scale output shorted to A_{GND} or zero-scale output shorted to V_{DD}		10			
	Short circuit current	V_{DD} = 2.7 V, full-scale output shorted to A_{GND} or zero-scale output shorted to V_{DD}		25		mA	
		V_{DD} = 5.5 V, full-scale output shorted to A_{GND} or zero-scale output shorted to V_{DD}		50			
		To V _{DD} (DAC output unloaded, internal reference = 1.21 V), V _{DD} \ge 1.21 X gain + 0.2 V		0.2		V	
	Output voltage headroom ⁽¹⁾	To V_{DD} (DAC output unloaded, reference tied to V_{DD})		0.8			
		To V _{DD} (I _{LOAD} = 10 mA at V _{DD} = 5.5 V, I _{LOAD} = 3 mA at V _{DD} = 2.7 V, I _{LOAD} = 1 mA at V _{DD} = 1.8 V), DAC code = full scale	10			%FSR	
		DAC output enabled and DAC code = midscale		0.25			
	V _{OUT} dc output impedance	DAC output enabled and DAC code = 4d		0.25		Ω	
		DAC output enabled and DAC code = 1016d		0.26			

(2) Specified by design and characterization, not production tested.

⁽¹⁾ Measured with DAC output unloaded. For external reference between end-point codes: 8d to 1016d for 10-bit resolution, 2d to 254d for 8-bit resolution. For internal reference V_{DD} ≥ 1.21 x gain + 0.2 V, between end-point codes: 8d to 1016d for 10-bit resolution, 2d to 254d for 8-bit resolution.

Electrical Characteristics (continued)

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.8 V $\leq V_{DD} \leq 5.5$ V, DAC reference tied to VDD, gain = 1x, DAC output pin (OUT) loaded with resistive load ($R_L = 5 \text{ k}\Omega$ to AGND) and capacitive load ($C_L = 200 \text{ pF}$ to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Zo	V _{FB} dc output impedance ⁽³⁾	DAC output enabled, DAC reference tied to VDD (gain = $1x$) or internal reference (gain = $1.5x$ or $2x$)	160	200	240	kΩ
		DAC output enabled, internal V_{REF} , gain = 3x or 4x	192	240	288	
	V _{OUT} + V _{FB} dc output leakage ⁽²⁾	At startup, measured when DAC output is disabled and held at V_{DD} / 2 for V_{DD} = 5.5 V			5	nA
	Power supply rejection ratio (dc)	Internal V _{REF} , gain = 2x, DAC at midscale; V _{DD} = 5 V \pm 10%		0.25		mV/V
DYN	AMIC PERFORMANCE	•			i.	
		1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, V_{DD} = 5.5 V		8		
sett	Output voltage settling time	1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, V_{DD} = 5.5 V, internal V_{REF} gain = 4x		12		μs
	Slew rate	V _{DD} = 5.5 V		1		V/µs
	Power on glitch magnitude	At startup (DAC output disabled), R_L = 5 k\Omega, C_L = 200 pF		75		mV
		At startup (DAC output disabled), $R_L = 100 \text{ k}\Omega$		200		
	Output enable glitch magnitude	DAC output disabled to enabled (DAC registers at zero scale, R_L = 100 $k\Omega$		250		mV
	Output noise voltage (peak to	0.1 Hz to 10 Hz, DAC at midscale, V_{DD} = 5.5 V		34		
/n	peak)	Internal V_{REF}, gain = 4x, 0.1 Hz to 10 Hz, DAC at midscale, V_{DD} = 5.5 V		70		μV _{PP}
		Measured at 1 kHz, DAC at midscale, V_{DD} = 5.5 V		0.2		
	Output noise density	Internal $V_{REF,}$ gain = 4x,, measured at 1 kHz, DAC at midscale, V_{DD} = 5.5 V		0.7		µV/√H
	Power supply rejection ratio (ac) ⁽³⁾	Internal V_{REF} , gain = 4x, 200-mV 50 or 60 Hz sine wave superimposed on power supply voltage, DAC at midscale		-71		dB
	Code change glitch impulse	±1 LSB change around mid code (including feedthrough)		10		nV-s
	Code change glitch impulse magnitude	±1 LSB change around mid code (including feedthrough)		15		mV
EPF	ROM					
	Endurance	$-40^{\circ}C \le T_A \le 85^{\circ}C$		20000		Cycle
				1000		Cycle
	Data retention ⁽²⁾	T _A = 25°C		50		Years
	EEPROM programming write cycle time ⁽²⁾		5	10	15	ms
JIGI	TAL INPUTS				<u>.</u>	
	Digital feedthrough	DAC output static at midscale, fast+ mode, SCL toggling		20		nV-s
	Pin capacitance	Per pin		10		pF
vow	ER					
	Load capacitor - CAP pin ⁽²⁾		0.5		15	μF
	Current flowing into VDD	Normal mode, DACs at full scale, digital pins static		0.5	0.8	mA
DD	Current flowing into VDD	DAC power-down, internal reference power down		80		μA

(3) Specified with 200-mV headroom with respect to reference value when internal reference is used.



7.6 Timing Requirements: I²C[™] Standard mode

all input signals are timed from VIL to 70% of V_{DD}, 1.8 V \leq V_{DD} \leq 5.5 V, -40°C \leq T_A \leq +125°C, 1.8 V \leq V_{pull-up} \leq V_{DD} V

	6		pull up DD	
		MIN	NOM MAX	UNIT
f _{SCLK}	SCL frequency		0.1	MHz
t _{BUF}	Bus free time between stop and start conditions	4.7		μs
t _{HDSTA}	Hold time after repeated start	4		μs
t _{SUSTA}	Repeated start setup time	4.7		μs
t _{SUSTO}	Stop condition setup time	4		μs
t _{HDDAT}	Data hold time	0		ns
t _{SUDAT}	Data setup time	250		ns
t _{LOW}	SCL clock low period	4700		ns
t _{HIGH}	SCL clock high period	4000		ns
t _F	Clock and data fall time		300	ns
t _R	Clock and data rise time		1000	ns

7.7 Timing Requirements: I²C[™] Fast mode

all input signals are timed from VIL to 70% of V_{DD}, 1.8 V \leq V_{DD} \leq 5.5 V, -40°C \leq T_A \leq +125°C, 1.8 V \leq V_{pul-up} \leq V_{DD} V

		MIN	NOM MAX	UNIT
f _{SCLK}	SCL frequency		0.4	MHz
t _{BUF}	Bus free time between stop and start conditions	1.3		μs
t _{HDSTA}	Hold time after repeated start	0.6		μs
t _{SUSTA}	Repeated start setup time	0.6		μs
t _{SUSTO}	Stop condition setup time	0.6		μs
t _{HDDAT}	Data hold time	0		ns
t _{SUDAT}	Data setup time	100		ns
t _{LOW}	SCL clock low period	1300		ns
t _{HIGH}	SCL clock high period	600		ns
t _F	Clock and data fall time		300	ns
t _R	Clock and data rise time		300	ns

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7.8 Timing Requirements: I²C[™] Fast+ mode

all input signals are timed from VIL to 70% of V_{DD}, 1.8 V \leq V_{DD} \leq 5.5 V, -40°C \leq T_A \leq +125°C, 1.8 V \leq V_{pull-up} \leq V_{DD} V

		MIN	NOM	MAX	UNIT
f _{SCLK}	SCL frequency			1	MHz
t _{BUF}	Bus free time between stop and start conditions	0.5			μs
t _{HDSTA}	Hold time after repeated start	0.26			μs
t _{SUSTA}	Repeated start setup time	0.26			μs
t _{SUSTO}	Stop condition setup time	0.26			μs
t _{HDDAT}	Data hold time	0			ns
t _{SUDAT}	Data setup time	50			ns
t _{LOW}	SCL clock low period	0.5			μs
t _{HIGH}	SCL clock high period	0.26			μs
t _F	Clock and data fall time			120	ns
t _R	Clock and data rise time			120	ns

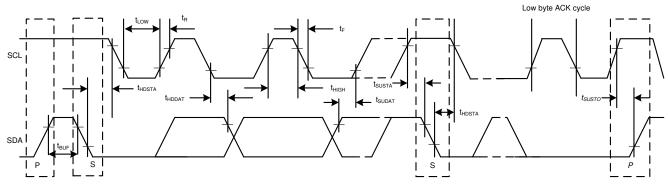
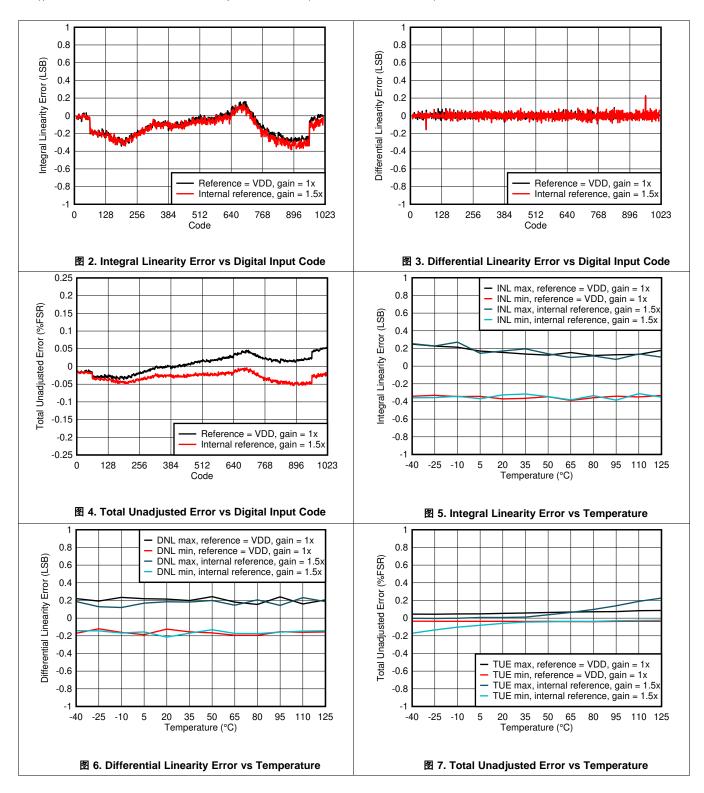


图 1. Timing Diagram



7.9 Typical Characteristics: $V_{DD} = 1.8 V$ (Reference = V_{DD}) or $V_{DD} = 2 V$ (Internal Reference)

at $T_A = 25^{\circ}C$, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)

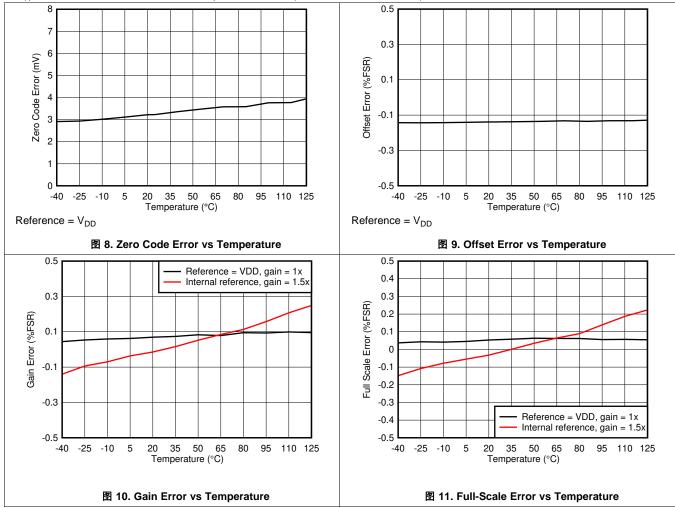


Texas Instruments

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Typical Characteristics: V_{DD} = 1.8 V (Reference = V_{DD}) or V_{DD} = 2 V (Internal Reference) (接下页)

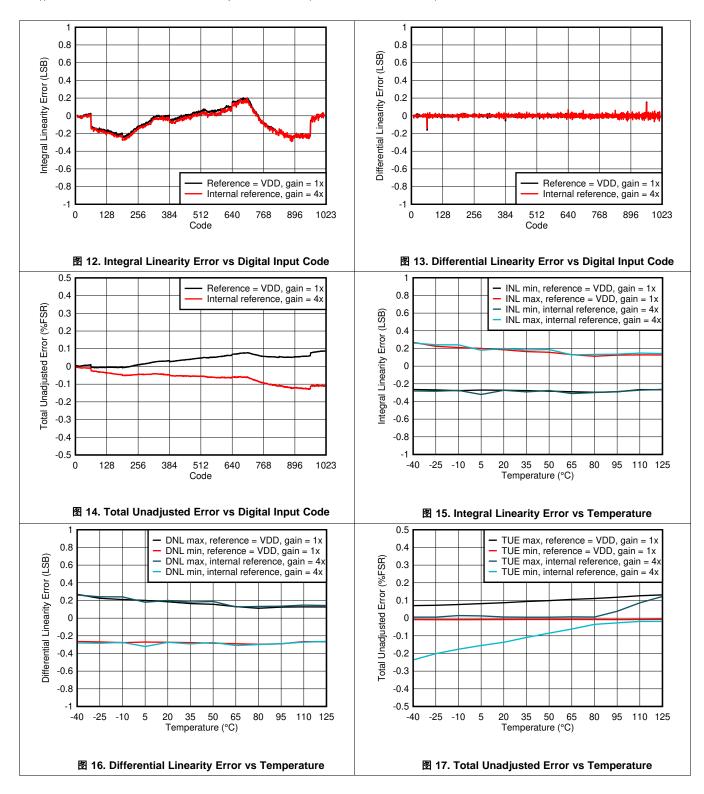
at $T_A = 25^{\circ}$ C, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)





7.10 Typical Characteristics: $V_{DD} = 5.5 V$ (Reference = V_{DD}) or $V_{DD} = 5 V$ (Internal Reference)

at T_A = 25°C, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)

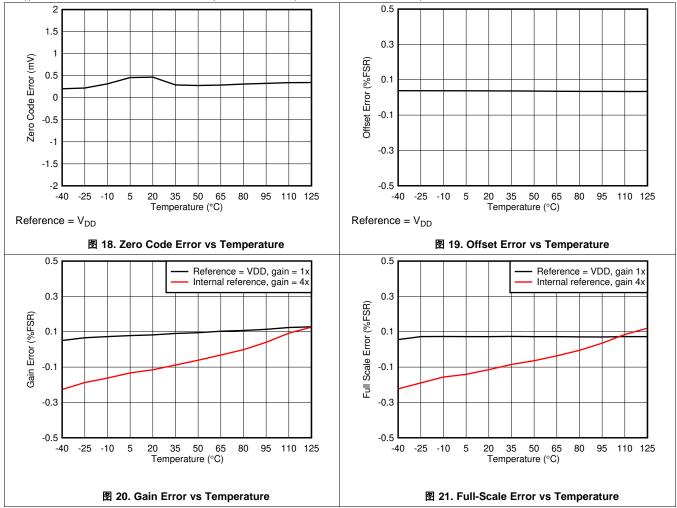


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Typical Characteristics: V_{DD} = 5.5 V (Reference = V_{DD}) or V_{DD} = 5 V (Internal Reference) (接下页)

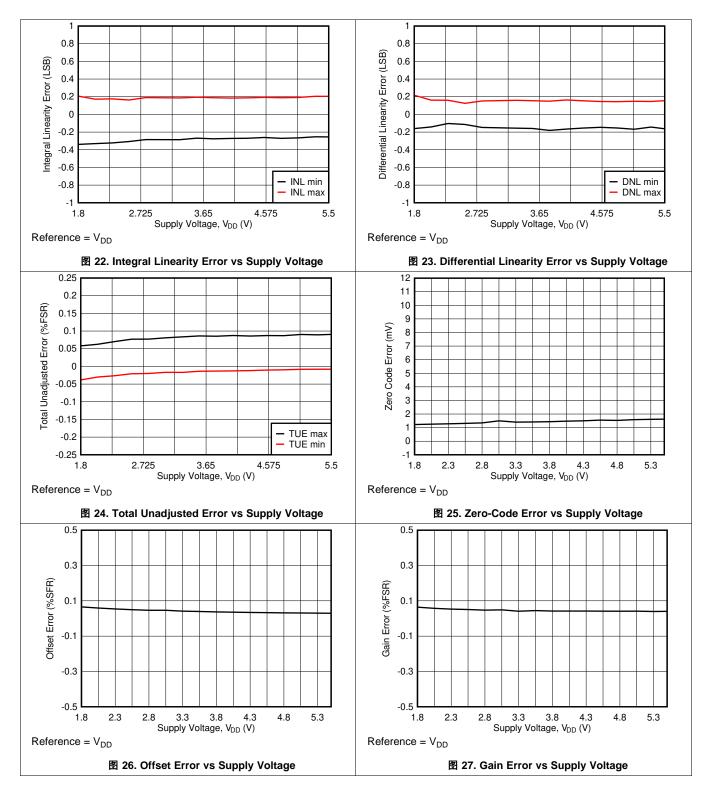
at $T_A = 25^{\circ}$ C, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)





7.11 Typical Characteristics

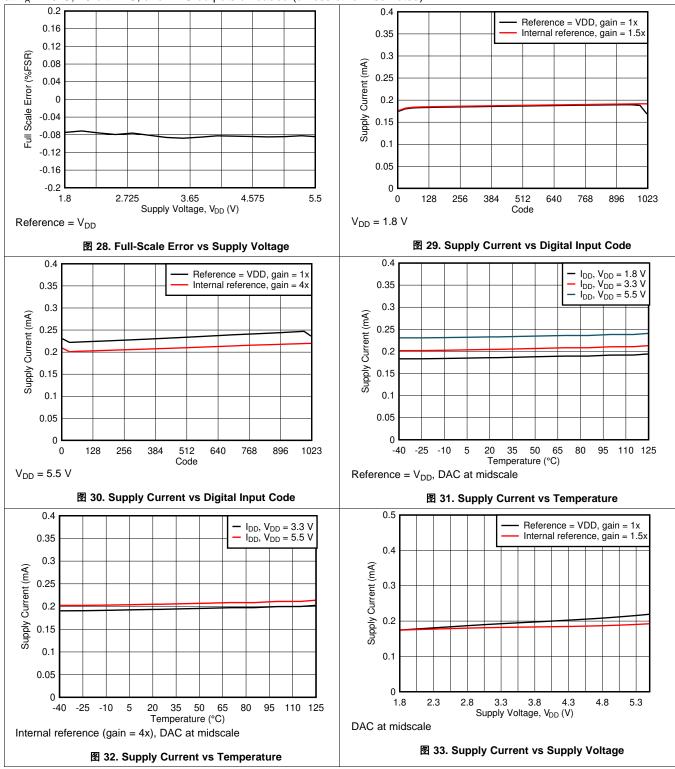
at T_A = 25°C, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)





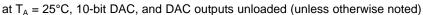
Typical Characteristics (接下页)

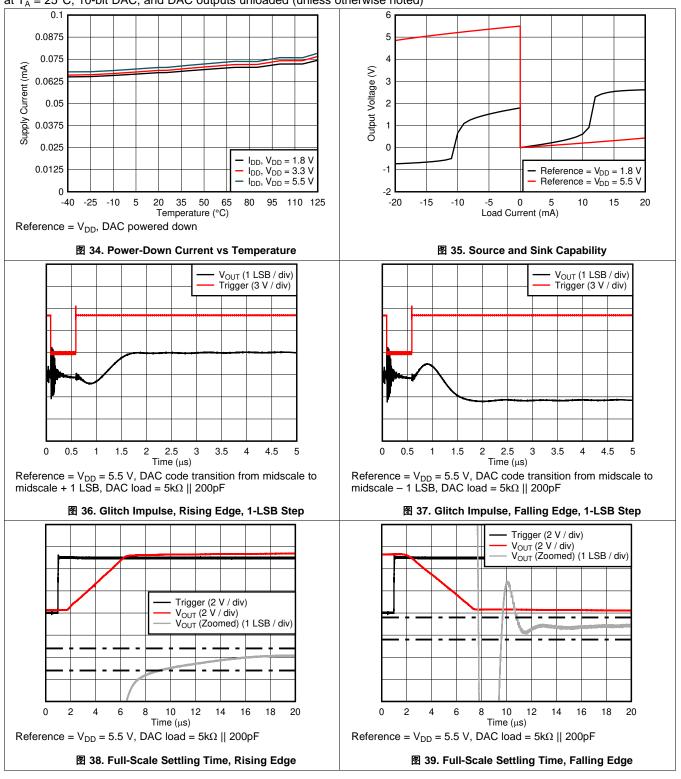
at T_A = 25°C, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)





Typical Characteristics (接下页)

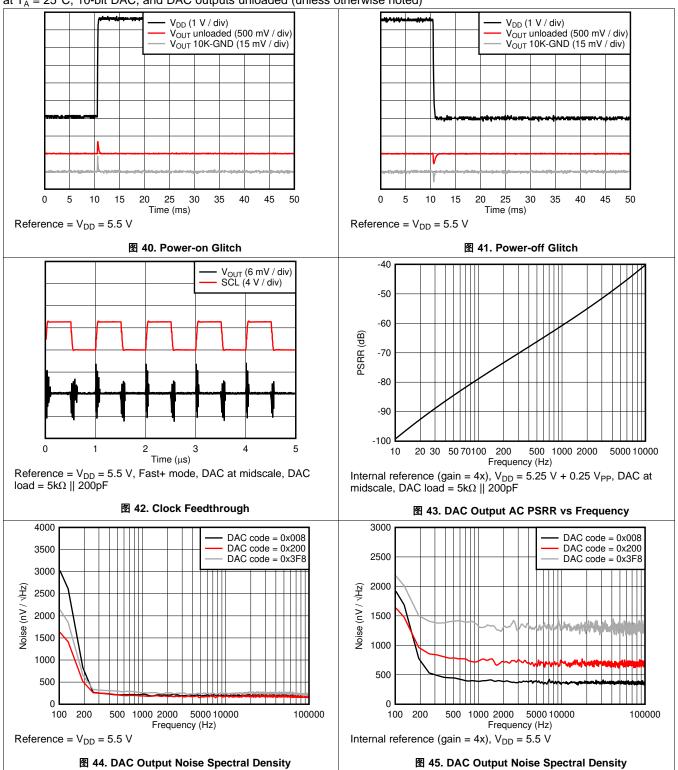






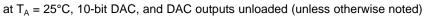
Typical Characteristics (接下页)

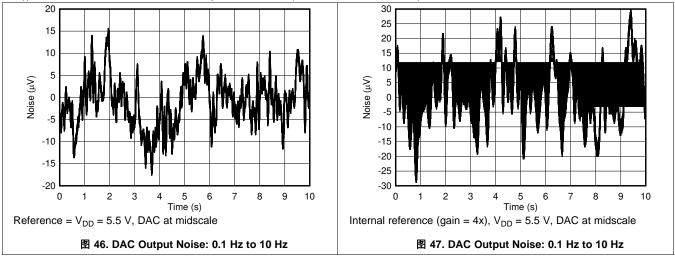
at T_A = 25°C, 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)





Typical Characteristics (接下页)





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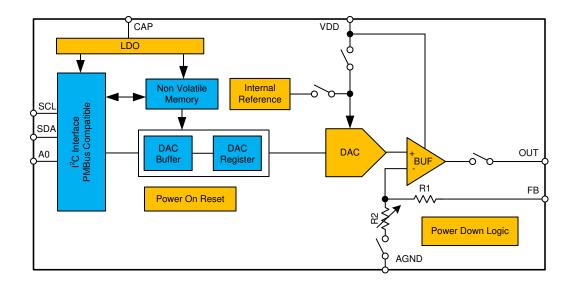
8 Detailed Description

8.1 Overview

The 10-bit DAC53401 and 8-bit DAC43401 (DACx3401) are a pin-compatible family of buffered voltage-output, digital-to-analog converters (DACs). These DACs contain nonvolatile memory (NVM), an internal reference, and a PMBus-compatible I²C interface. The DACx3401 operate with either an internal reference or with a power supply as the reference, and provide a full-scale output of 1.8 V to 5.5 V.

The devices communicate through an I²C interface. These devices support I²C standard mode (100 kbps), fast mode (400 kbps), and fast+ mode (1 Mbps). These devices also support specific PMBus commands such as *turn on/off, margin high/low*, and more. The DACx3401 also include digital slew rate control, and support basic signal generation such as *square, ramp*, and *sawtooth* waveforms.

The DACx3401 devices have a power-on-reset (POR) circuit that makes sure all the registers start with default or user-programmed settings using NVM. The DAC output powers on in high-impedance mode (default); this setting can be programmed to $10k\Omega$ -GND using NVM.



8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Digital-to-Analog Converter (DAC) Architecture

The DACx3401 family of devices consists of string architecture with an output buffer amplifier. The *Functional Block Diagram* section shows the DAC architecture within the block diagram. This DAC architecture operates from a 1.8-V to 5.5-V power supply. These devices consume only 0.2 mA of current when using a 1.8-V power supply. The DAC output pin starts up in high impedance mode making it an excellent choice for power-supply control applications. To change the power-up mode to $10k\Omega$ -GND, program the DAC_PDN bit (address: D1h), and load these bits in the device NVM.

8.3.1.1 Reference Selection and DAC Transfer Function

The device writes the input data to the DAC data registers in straight-binary format. After a power-on or a reset event, the device sets all DAC registers to the values set in the NVM.

8.3.1.1.1 Power Supply as Reference

By default, the DACx3401 operate with the power-supply pin (VDD) as a reference. 公式 1 shows DAC transfer function when the power-supply pin is used as reference.

$$V_{OUT} = \frac{DAC_DATA}{2^N} \times V_{DD}$$

where:

- N is the resolution in bits, either 8 (DAC43401) or 10 (DAC53401).
- DAC_DATA is the decimal equivalent of the binary code that is loaded to the DAC register.
- DAC_DATA ranges from 0 to $2^{N} 1$.
- V_{DD} is used as the DAC reference voltage.

8.3.1.1.2 Internal Reference

The DACx3401 also contain an internal reference that is disabled by default. Enable the internal reference by writing 1 to REF_EN (address D1h). The internal reference generates a fixed 1.21-V voltage (typical). Using DAC_SPAN (address D1h) bits, gain of 1.5X, 2X, 3X, 4X can be achieved for the DAC output voltage (V_{OUT}) $\stackrel{\frown}{\propto}$ 2 shows DAC transfer function when the internal reference is used.

$$V_{OUT} = \frac{DAC_DATA}{2^N} \times V_{REF} \times GAIN$$

where:

- N is the resolution in bits, either 8 (DAC43401) or 10 (DAC53401).
- DAC_DATA is the decimal equivalent of the binary code that is loaded to the DAC register
- DAC_DATA ranges from 0 to $2^{N} 1$.
- V_{REF} is the internal reference voltage = 1.21 V.
- GAIN = 1.5x, 2x, 3x, 4x based on DAC_SPAN (address D1h) bits.

(2)

(1)

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Feature Description (接下页)

8.3.2 DAC Update

The DAC output pin (OUT) is updated at the end of I²C DAC write frame.

8.3.2.1 DAC Update Busy

The DAC_UPDATE_BUSY bit (address D0h) is set to 1 by the device when certain DAC update operations, such as *function generation*, *transition to margin high or low*, or any of the medical alarms are in progress. When the DAC_UPDATE_BUSY bit is set to 1, do not write to any of the DAC registers. After the DAC update operation is completed (DAC_UPDATE_BUSY = 0), any of the DAC registers can be written.

8.3.3 Nonvolatile Memory (EEPROM or NVM)

The DACx3401 contain nonvolatile memory (NVM) bits. These memory bits are user programmable and erasable, and retain the set values in the absence of a power supply. All the register bits, as shown in $\frac{1}{8}$ 1, can be stored in the device NVM by setting NVM_PROG = 1 (address D3h). The NVM_BUSY bit (address D0h) is set to 1 by device when a NVM write or reload operation is ongoing. During this time, the device blocks all write operations to the device. The NVM_BUSY bit is set to 0 after the write or reload operation is complete; at this point, all write operations to the device are allowed. The default value for all the registers in the DACx3401 is loaded from NVM as soon as a POR event is issued. Do not perform a read operation from the DAC register while NVM_BUSY = 1.

The DACx3401 also implement NVM_RELOAD bit (address D3h). Set this bit to 1 for the device to start an NVM reload operation. After the operation is complete, the device autoresets this bit to 0. During the NVM_RELOAD operation, the NVM_BUSY bit is set to 1.

REGISTER ADDRESS	REGISTER NAME	BIT ADDRESS	BIT NAME
		15:14	FUNC_CONFIG
		13	DEVICE_LOCK
		11:9	CODE_STEP
D1h	GENERAL_CONFIG	8:5	SLEW_RATE
		4:3	DAC_PDN
		2	REF_EN
		1:0	DAC_SPAN
	MED_ALARM_CONFIG	10	MED_ALARM_HP
		9	MED_ALARM_MP
D2h		8	MED_ALARM_LP
D2N		5:4	INTERBURST_TIME
		3:2	PULSE_OFF_TIME
		1:0	PULSE_ON_TIME
D3h	TRIGGER	8	START_FUNC_GEN
10h	DAC_DATA	11:2	DAC_DATA
25h	DAC_MARGIN_HIGH	11:4	MARGIN_HIGH (8 most significant bits)
26h	DAC_MARGIN_LOW	11:4	MARGIN_LOW (8 most significant bits)

表 1. NVM Programmable Registers



8.3.3.1 NVM Cyclic Redundancy Check

The DACx3401 implement a cyclic redundancy check (CRC) feature for the device NVM to make sure that the data stored in the device NVM is uncorrupted. There are two types of CRC alarm bits implemented in DACx3401: NVM_CRC_ALARM_USER and NVM_CRC_ALARM_INTERNAL. The NVM_CRC_ALARM_USER bit indicates the status of user-programmable NVM bits, and the NVM_CRC_ALARM_INTERNAL bit indicates the status of internal NVM bits The CRC feature is implemented by storing a 10-Bit CRC (CRC-10-ATM) along with the NVM data each time NVM program operation (write or reload) is performed and during the device start up. The device reads the NVM data and validates the data with the stored CRC. The CRC alarm bits (NVM_CRC_ALARM_USER and NVM_CRC_ALARM_INTERNAL address D0h) report any errors after the data are read from the device NVM.

8.3.3.2 NVM_CRC_ALARM_USER Bit

A logic 1 on NVM_CRC_ALARM_USER bit indicates that the user-programmable NVM data is corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. To reset the alarm bits to 0, issue a software reset (see the *Software Reset* section) command, or cycle power to the DAC. Alternatively, cycle the power to reload the user-programmable NVM bits.

8.3.3.3 NVM_CRC_ALARM_INTERNAL Bit

A logic 1 on NVM_CRC_ALARM_INTERNAL bit indicates that the internal NVM data is corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. To reset the alarm bits to 0, issue a software reset (see the *Software Reset* section) command or cycle power to the DAC.

8.3.4 Programmable Slew Rate

When the DAC data registers are written, the voltage on DAC output (V_{OUT}) immediately transitions to the new code following the slew rate and settling time specified in the *Electrical Characteristics* table. The slew rate control feature allows the user to control the rate at which the output voltage (V_{OUT}) changes. When this feature is enabled (using SLEW_RATE[3:0] bits), the DAC output changes from the current code to the code in MARGIN_HIGH (address 25h) or MARGIN_LOW (address 26h) registers (when margin high or low commands are issued to the DAC) using the step and rate set in CODE_STEP and SLEW_RATE bits. With the default slew rate control setting (CODE_STEP and SLEW_RATE bits, address D1h), the output changes smoothly at a rate limited by the output drive circuitry and the attached load. Using this feature, the output steps digitally at a rate defined by bits CODE_STEP and SLEW_RATE on address D1h. SLEW_RATE defines the rate at which the digital slew updates; CODE_STEP defines the amount by which the output value changes at each update. $\frac{1}{3}$ 2 and $\frac{1}{3}$ 3 show different settings for CODE_STEP and SLEW_RATE.

When the slew rate control feature is used, the output changes happen at the programmed slew rate. This configuration results in a staircase formation at the output. Do not write to CODE_STEP, SLEW_RATE, or DAC_DATA during the output slew.

REGISTER ADDRESS AND NAME	CODE_STEP[2]	CODE_STEP[1]	CODE_STEP[0]	COMMENT
	0	0	0	Code step size = 1 LSB (default)
	0	0	1	Code step size = 2 LSB
	0	1	0	Code step size = 3 LSB
D1h, GENERAL_CONFIG	0	1	1	Code step size = 4 LSB
	1	0	0	Code step size = 6 LSB
	1	0	1	Code step size = 8 LSB
	1	1	0	Code step size = 16 LSB
	1	1	1	Code step size = 32 LSB

表 2. Code Step

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REGISTER ADDRESS AND NAME	SLEW_RATE[3]	SLEW_RATE[2]	SLEW_RATE[1]	SLEW_RATE[0]	COMMENT
	0	0	0	0	25.6 μs (per step)
	0	0	0	1	25.6 µs × 1.25 (per step)
	0	0	1	0	25.6 µs × 1.50 (per step)
	0	0	1	1	25.6 µs × 1.75 (per step)
	0	1	0	0	204.8 µs (per step)
	0	1	0	1	204.8 μs × 1.25 (per step)
D1h,	0	1	1	0	204.8 μs × 1.50 (per step)
GENERAL_CONFIG	0	1	1	1	204.8 μs × 1.75 (per step)
	1	0	0	0	1.6384 ms (per step)
	1	0	0	1	1.6384 ms × 1.25 (per step)
	1	0	1	0	1.6384 ms × 1.50 (per step)
	1	0	1	1	1.6384 ms × 1.75 (per step)
	1	1	0	0	12 µs (per step)
	1	1	0	1	8 µs (per step)
	1	1	1	0	4 µs (per step)
					1

1

1

No slew (default)

1

表 3. Slew Rate



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8.3.5 Power-on-Reset (POR)

The DACx3401 family of devices includes a power-on reset (POR) function that controls the output voltage at power up. After the V_{DD} supply has been established, a POR event is issued. The POR causes all registers to initialize to default values, and communication with the device is valid only after a 30-ms, POR delay. The default value for all the registers in the DACx3401 is loaded from NVM as soon as the POR event is issued.

When the device powers up, a POR circuit sets the device to the default mode. The POR circuit requires specific V_{DD} levels, as indicated in 🕅 48, in order to make sure that the internal capacitors discharge and reset the device on power up. To make sure that a POR occurs, V_{DD} must be less than 0.7 V for at least 1 ms. When V_{DD} drops to less than 1.65 V, but remains greater than 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power-supply conditions. In this case, initiate a POR. When V_{DD} remains greater than 1.65 V, a POR does not occur.

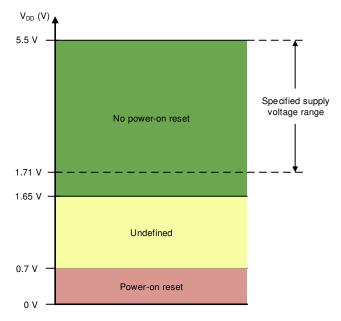


图 48. Threshold Levels for V_{DD} POR Circuit

8.3.6 Software Reset

To initiate a device software reset event, write the reserved code 1010 to the SW_RESET (address D3h). A software reset initiates a POR event.

8.3.7 Device Lock Feature

The DACx3401 implement a device lock feature that prevents an accidental or unintended write to the DAC registers. The device locks all the registers when the DEVICE_LOCK bit (address D1h) is set to 1. To bypass the DEVICE_LOCK setting, write 0101 to the DEVICE_UNLOCK_CODE bits (address D3h).



8.3.8 PMBus Compatibility

Similar to I^2C , PMBus is a variable length packet of 8-bit data bytes, each with a receiver acknowledge, wrapped between a start and stop bit. The first byte is always a 7-bit *slave address* followed by a *write* bit, sometimes called the *even address* that identifies the intended receiver of the packet. The second byte is an 8-bit *command* byte, identifying the PMBus command being transmitted using the respective command code. After the command byte, the transmitter either sends data associated with the command to write to the receiver command register (from most significant byte to least significant byte), or sends a new start bit indicating the desire to read the data associated with the command register transmits the data following the same most significant byte first format (see ≥ 10).

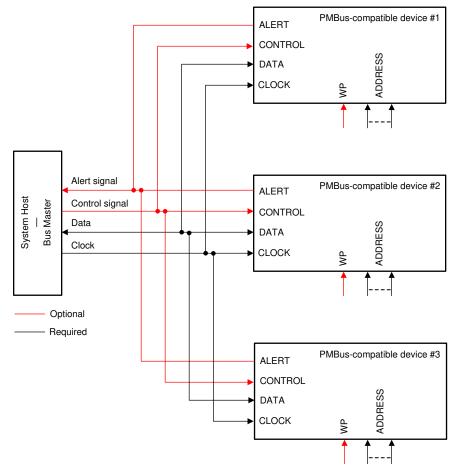


图 49. PMBus Connections

8.4 Device Functional Modes

8.4.1 Power Down Mode

The DACx3401 output amplifier and internal reference can be independently powered down through the DAC_PDN bits (address D1h). At power up, the DAC output and the internal reference are disabled by default. In power-down mode, the DAC output (OUT pin) is in a high-impedance state. To change this state to $10k\Omega$ -A_{GND} (at power up), use the DAC_PDN bits (address D1h).

The DAC power-up state can be programmed to any state (power-down or normal mode) using the NVM. 表 4 shows the DAC power-down bits.

REGISTER ADDRESS AND NAME	DAC_PDN[1]	DAC_PDN[0]	DESCRIPTION
	0	0	Power up
	0	1	Power down to 10 kΩ
D1h, GENERAL_CONFIG	1	0	Power down to high impedance (HiZ) (default)
	1	1	Power down to 10 kΩ

表 4. DAC Power-Down Bits

8.4.2 Continuous Waveform Generation (CWG) Mode

The DACx3401 implement a continuous waveform generation feature. To set the device to this mode, set the START_FUNC_GEN (address D3h) to 1. In this mode, the DAC output pin (OUT) generates a continuous waveform based on the FUNC_CONFIG bits (address D1h). 表 5 shows the continuous waveforms that can be generated in this mode. The frequency of the waveform depends on the resistive and capacitive load on the OUT pin, high and low codes, and slew rate settings as shown in the following equations.

$$f_{SQUARE-WAVE} = \frac{1}{2 \times SLEW RATE}$$

where:

• SLEW_RATE is the programmable DAC slew rate specified in 表 3.

$$f_{TRIANGLE-WAVE} = \frac{I}{2 \times SLEW_RATE \times \left(\frac{MARGIN_HIGH - MARGIN_LOW + 1}{CODE_STEP}\right)}$$

where:

- SLEW_RATE is the programmable DAC slew rate specified in 表 3.
- MARGIN_HIGH and MARGIN_LOW are the programmable DAC codes.
- CODE_STEP is the programmable DAC step code in 表 2.

$$\mathsf{DOTH-WAVE} = \frac{\mathsf{MARGIN}_{\mathsf{HIGH}} - \mathsf{MARGIN}_{\mathsf{LOW}} + 1}{\mathsf{SLEW}_{\mathsf{RATE}} \times \left(\frac{\mathsf{MARGIN}_{\mathsf{HIGH}} - \mathsf{MARGIN}_{\mathsf{LOW}} + 1}{\mathsf{CODE}_{\mathsf{STEP}}}\right)}$$

1

where:

- SLEW_RATE is the programmable DAC slew rate specified in 表 3.
- MARGIN_HIGH and MARGIN_LOW are the programmable DAC codes.
- CODE_STEP is the programmable DAC step code in 表 2.

(5)

(3)

(4)

表 5. FUNC_CONFIG bits						
REGISTER ADDRESS AND NAME	FUNC_CONFIG[1]	FUNC_CONFIG[0]	DESCRIPTION			
	0	0	Generates a triangle wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with slope defined by SLEW_RATE (address D1h) bits			
	0	1	Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with rising slope defined by SLEW_RATE (address D1h) bits and immediate falling edge			
D1h, GENERAL_CONFIG	1	0	Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with falling slope defined by SLEW_RATE (address D1h) bits and immediate rising edge			
	1	1	Generates a square wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with pulse high and low period defined by SLEW_RATE (address D1h) bits			

8.4.3 PMBus Compatibility Mode

The DACx3401 I²C interface implements some of the PMBus commands. 表 6 shows the supported PMBus commands that are implemented in DACx3401.The DAC uses MARGIN_LOW (address 26h), MARGIN_HIGH (address 25h) bits, SLEW_RATE, and CODE_STEP bits (address D1h) for PMBUS_OPERATION_CMD. The EN_PMBus bit (Bit 12, address D1h) must be set to 1 to enable the PMBus protocol.

表 6. P	MBus	Operation	Commands
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REGISTER ADDRESS AND NAME	PMBUS_OPERATION_CMD[15:8]	DESCRIPTION
	00h	Turn off
	80h	Turn on
01h, PMBUS_OPERATION	94h	Margin low
	A4h	Margin high

The DACx3401 also implement PMBus features such as group command protocol and communication time-out failure. The CML bit (address 78h) indicates a communication fault in the PMBus. This bit is reset by writing 1. In case of timeout, if the SDA line is held low, the SDA line stays low during the time-out event until next SCL pulse is received.

To get the PMBus version, read the PMBUS_VERSION bits (address 98h).

8.4.4 Medical Alarm Generation Mode

The DACx3401 are also used to generate continuous alarm tones for medical devices. Use a suitable analog mixer, audio amplifier, and a speaker to generate low, medium, or high priority alarm tones. See the *Application and Implementation* section for more details. The DACx3401 allow tunability and configurability to support different alarm generation. Using this approach, configurable medical alarm tones can be generated with a simple circuit, and with no need for runtime software.

8.4.4.1 Low-Priority Alarm

The MED_ALARM_LP bit (address D2h) is used to trigger a medical low-priority alarm generation. The DAC generates a continuous-alarm signal until this bit is set back to 0. After the bit is set to 0, the device does not abruptly end the alarm generation; the device stops only after completing the ongoing burst.



8.4.4.2 Medium-Priority Alarm

The MED_ALARM_MP bit (address D2h) is used to trigger a medical medium-priority alarm generation. The DAC generates a continuous-alarm signal until this bit is set back to 0. After the bit is set to 0, the device does not abruptly end the alarm generation; the device stops only after completing the ongoing burst.

8.4.4.3 High-Priority Alarm

The MED_ALARM_HP bit (address D2h) is used to trigger a medical high-priority alarm generation. The DAC generates a continuous-alarm signal until this bit is set back to 0. After the bit is set to 0, the device does not abruptly end the alarm generation; the device stops only after completing the ongoing burst.

8.4.4.4 Interburst Time

The INTERBURST_TIME bit (address D2h) is used set the time between two adjacent bursts. 表 7 lists the INTERBURST_TIME settings.

REGISTER ADDRESS AND NAME	INTERBURST_TIME[1:0]	HIGH PRIORITY ALARM INTERBURST TIME	MEDIUM PRIORITY ALARM INTERBURST TIME	LOW PRIORITY ALARM INTERBURST TIME
	00	2.55 s	2.60 s	
D2h,	01	2.96 s	3.06 s	16 a
MED_ALARM_CONFIG	10	3.38 s	3.52 s	16 s
	11	3.80 s	4.00 s	

表 7. Interburst Time

8.4.4.5 Pulse Off Time

The PULSE_OFF_TIME bit (address D2h) is used to control the low period of trapezoid in a medical alarm waveform. 表 8 lists the PULSE_OFF_TIME settings.

表8	3. P	ulse	Off	Time
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REGISTER ADDRESS AND NAME	PULSE_OFF_TIME[1:0]	HIGH PRIORITY ALARM PULSE OFF TIME	MEDIUM PRIORITY ALARM PULSE OFF TIME	LOW PRIORITY ALARM PULSE OFF TIME
	00	15 ms	40 ms	40 ms
D2h,	01	36 ms	60 ms	60 ms
MED_ALARM_CONFIG	10	58 ms	80 ms	80 ms
	11	80 ms	100 ms	100 ms

8.4.4.6 Pulse On Time

The PULSE_ON_TIME bit (address D2h) controls the high period of trapezoid in a medical alarm waveform. 表 9 lists the PULSE_ON_TIME settings.

表 9. Pulse On Time

REGISTER ADDRESS AND NAME	PULSE_ON_TIME[1:0]	HIGH PRIORITY ALARM PULSE ON TIME	MEDIUM PRIORITY ALARM PULSE ON TIME	LOW PRIORITY ALARM PULSE ON TIME
	00	80 ms	130 ms	130 ms
D2h,	01	103 ms	153 ms	153 ms
MED_ALARM_CONFIG	10	126 ms	176 ms	176 ms
	11	150 ms	200 ms	200 ms



8.5 Programming

The DACx3401 devices have a 2-wire serial interface (SCL and SDA), and one address pin (A0), as shown in the *Pin Configuration and Functions* section. The I²C bus consists of a data line (SDA) and a clock line (SCL) with pullup structures. When the bus is idle, both SDA and SCL lines are pulled high. All the I²C-compatible devices connect to the I²C bus through the open drain I/O pins, SDA and SCL.

The I²C specification states that the device that controls communication is called a *master*, and the devices that are controlled by the master are called *slaves*. The master device generates the SCL signal. The master device also generates special timing conditions (start condition, repeated start condition, and stop condition) on the bus to indicate the start or stop of a data transfer. Device addressing is completed by the master. The master device on an I²C bus is typically a microcontroller or digital signal processor (DSP). The DACx3401 family operates as a slave device on the I²C bus. A slave device acknowledges master commands, and upon master control, receives or transmits data.

Typically, the DACx3401 family operates as a slave receiver. A master device writes to the DACx3401, a slave receiver. However, if a master device requires the DACx3401 internal register data, the DACx3401 operate as a slave transmitter. In this case, the master device reads from the DACx3401. According to I²C terminology, read and write refer to the master device.

The DACx3401 family is a slave and supports the following data transfer modes:

- Standard mode (100 kbps)
- Fast mode (400 kbps)
- Fast+ mode (1.0 Mbps)

The data transfer protocol for standard and fast modes is exactly the same; therefore, both modes are referred to as F/S-mode in this document. The fast+ mode protocol is supported in terms of data transfer speed, but not output current. The low-level output current would be 3 mA; similar to the case of standard and fast modes. The DACx3401 family supports 7-bit addressing. The 10-bit addressing mode is not supported. The device supports the general call reset function. Sending the following sequence initiates a software reset within the device: start or repeated start, 0x00, 0x06, stop. The reset is asserted within the device on the rising edge of the ACK bit, following the second byte.

Other than specific timing signals, the I^2C interface works with serial bytes. At the end of each byte, a ninth clock cycle generates and detects an acknowledge signal. Acknowledge is when the SDA line is pulled low during the high period of the ninth clock cycle. A not-acknowledge is when the SDA line is left high during the high period of the ninth clock cycle as shown in \mathbb{R} 50.

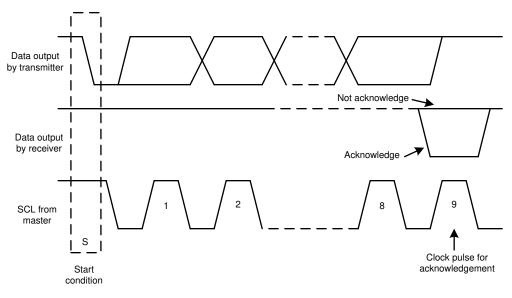


图 50. Acknowledge and Not Acknowledge on the I²C Bus



Programming (接下页)

8.5.1 F/S Mode Protocol

The following steps explain a complete transaction in F/S mode.

- 1. The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in 图 51. All I²C-compatible devices recognize a start condition.
- 2. The master then generates the SCL pulses, and transmits the 7-bit address and the read/write direction bit (R/W) on the SDA line. During all transmissions, the master makes sure that data are valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse, as shown in 图 52. All devices recognize the address sent by the master and compare the address to the respective internal fixed address. Only the slave device with a matching address generates an acknowledge by pulling the SDA line low during the entire high period of the 9th SCL cycle, as shown in 图 50. When the master detects this acknowledge, the communication link with a slave has been established.
- 3. The master generates further SCL cycles to transmit (R/W bit 0) or receive (R/W bit 1) data to the slave. In either case, the receiver must acknowledge the data sent by the transmitter. The acknowledge signal can be generated by the master or by the slave, depending on which is the receiver. The 9-bit valid data sequences consists of 8-data bits and 1 acknowledge-bit, and can continue as long as necessary.
- 4. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low-to-high while the SCL line is high (see 图 51). This action releases the bus and stops the communication link with the addressed slave. All l²C-compatible devices recognize the stop condition. Upon receipt of a stop condition, the bus is released, and all slave devices then wait for a start condition followed by a matching address.

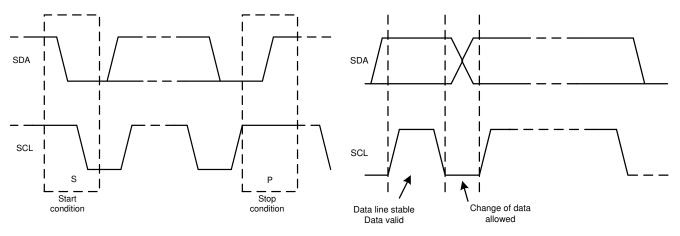


图 51. Start and Stop Conditions

图 52. Bit Transfer on the I²C Bus

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8.5.2 DACx3401 I²C Update Sequence

For a single update, the DACx3401 require a start condition, a valid I^2C address byte, a command byte, and two data bytes, as listed in $\frac{1}{5}$ 10.

MSB		LSB	ACK	MSB		LSB	ACK	MSB		LSB	ACK	MSB		LSB	ACK
	lress (A) ddress By				mmand b m <mark>mand E</mark>	,			i byte - N ication C			Data byte - Application			
C	DB [31:24	1]		0	DB [23:16	6]			DB [15:8]			DB [7:0]		

表 10. Update	Sequence
--------------	----------

After each byte is received, the DACx3401 family acknowledges the byte by pulling the SDA line low during the high period of a single clock pulse, as shown in 853. These four bytes and acknowledge cycles make up the 36 clock cycles required for a single update to occur. A valid I²C address byte selects the DACx3401 devices.

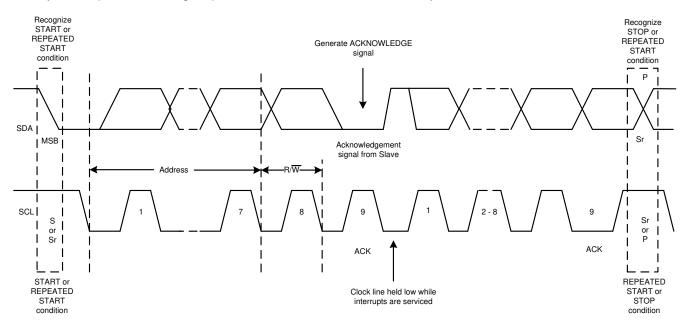


图 53. I²C Bus Protocol

The command byte sets the operating mode of the selected DACx3401 device. For a data update to occur when the operating mode is selected by this byte, the DACx3401 device must receive two data bytes: the most significant data byte (MSDB) and least significant data byte (LSDB). The DACx3401 device performs an update on the falling edge of the acknowledge signal that follows the LSDB.

When using fast mode (clock = 400 kHz), the maximum DAC update rate is limited to 10 kSPS. Using the fast+ mode (clock = 1 MHz), the maximum DAC update rate is limited to 25 kSPS. When a stop condition is received, the DACx3401 device releases the l^2C bus and awaits a new start condition.

8.5.3 Address Byte

The address byte, as shown in $\frac{11}{5}$ 11, is the first byte received following the start condition from the master device. The first four bits (MSBs) of the address are factory preset to 1001. The next three bits of the address are controlled by the A0 pin. The A0 pin input can be connected to VDD, AGND, SCL, or SDA. The A0 pin is sampled during the first byte of each data frame to determine the address. The device latches the value of the address pin, and consequently responds to that particular address according to $\frac{1}{5}$ 12.

The DACx3401 family supports broadcast addressing, which can be used for synchronously updating or powering down multiple DACx3401 devices. The DACx3401 family is designed to work with other members of the family to support multichip synchronous updates. Using the broadcast address, the DACx3401 devices respond regardless of the states of the address pins. Broadcast is supported only in write mode.



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表 11. Address Byte

COMMENT				MSB				LSB
—	AD6	AD5	AD4	AD3	AD2	AD1	AD0	R/W
General address	1	0	0	1	See 表 12	(slave address	s column)	0 or 1
Broadcast address	1	0	0	0	1	1	1	0

表 12. Address Format

SLAVE ADDRESS	A0 PIN
000	AGND
001	VDD
010	SDA
011	SCL

8.5.4 Command Byte

Table 16 lists the command byte.

ADDRESS	REGISTER NAME
D0h	STATUS
D1h	GENERAL_CONFIG
D2h	MED_ALARM_CONFIG
D3h	TRIGGER
21h	DAC_DATA
25h	DAC_MARGIN_HIGH
26h	DAC_MARGIN_LOW
01h	PMBUS_OP
78h	PMBUS_STATUS_BYTE
98h	PMBUS_VERSION

表 13. Command Byte (Register Names)

8.5.5 I²C Read Sequence

To read any register the following command sequence must be used:

- 1. Send a start or repeated start command with a slave address and the R/W bit set to 0 for writing. The device acknowledges this event.
- 2. Send a command byte for the register to be read. The device acknowledges this event again.
- 3. Send a repeated start with the slave address and the R/W bit set to 1 for reading. The device acknowledges this event.
- 4. The device writes the MSDB byte of the addressed register. The master must acknowledge this byte.
- 5. Finally, the device writes out the LSDB of the register.

An alternative reading method allows for reading back the value of the last register written. The sequence is a start or repeated start with the slave address and the R/W bit set to 1, and the two bytes of the last register are read out.

Note that it is not possible to use the broadcast address for reading.

s	MSB		R/W (0)	АСК	MSB		LSB	ACK	Sr	MSB		R/W (1)	АСК	MSB		LSB	ACK	MSB		LSB	АСК
	BYTE	DRE: E Ado Byte	lress		E	MMA 3YTE nanc			Sr	ADDRESS			N	ISDI	В		L	.SDE	3		
	From I	Maste	ər	Slave	From	n Ma	aster	Slave	From Master		Slave	Fro	m Sl	ave	Master	Fro	m Sl	ave	Master		

表 14. Read Sequence

8.6 Register Map

Table 15. Register Map

			MOST	SIGNIFICANT	DATA BYTE ((MSDB)					LEAST	SIGNIFICAN	DATA BYTE	(LSDB)		
ADDRESS	BIT15	BIT14	BIT13	BIT12	BIT11	BIT10	BIT9	BIT8	BIT7	BIT6	BIT5	BIT4	BIT3	BIT2	BIT1	BIT0
D0h	NVM_CRC_ ALARM_ USER	NVM_CRC_ ALARM_ INTERNAL	NVM_BUSY	DAC_ UPDATE_ BUSY			x	(1)				DEVI	CE_ID		VERSI	ON_ID
D1h	FUNC_0	CONFIG	DEVICE_ LOCK	EN_PMBUS		CODE_STEP			SLEW	SLEW_RATE DAC_F			_PDN	REF_EN	DAC_	SPAN
D2h			Х			MED_ MED_ MED_ ALARM_HP ALARM_MP ALARM_LP				RESERVED INTERBU			JRST_TIME PULSE_OFF_TIME			ON_TIME
D3h		DEVICE_UN	LOCK_CODE			х	DEVICE_ CONFIG_ RESET	START_ FUNC_ GEN	PMBUS_ MARGIN_ HIGH	PMBUS_ MARGIN_ LOW	NVM_ RELOAD				ESET	
21h			Х					DAC_DAT	TA[9:0] (10-Bit) or DAC_DATA[7:0] (8-Bit)						>	<
25h			Х					MARGIN_HIG	H[9:0] (10-Bit)	or MARGIN_HI	GH[7:0] (8-Bit)				>	<
26h			Х					MARGIN_LOV	N[9:0] (10-Bit)	or MARGIN_LC	DW[7:0] (8-Bit)				>	<
01h				PMBUS_OPER	RATION_CMD							N	/A			
78h			2	х			CML					N/A				
98h		PMBUS_VERSION										N	/A			

(1) X = Don't care.



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Table 16. Register Names

ADDRESS	REGISTER NAME	SECTION
D0h	STATUS	STATUS Register (address = D0h) (reset = 000Ch or 0014h)
D1h	GENERAL_CONFIG	GENERAL_CONFIG Register (address = D1h) (reset = 01F0h)
D2h	MED_ALARM_CONFIG	MED_ALARM_CONFIG Register (address = D2h) (reset = 0000h)
D3h	TRIGGER	TRIGGER Register (address = D3h) (reset = 0008h)
21h	DAC_DATA	DAC_DATA Register (address = 21h) (reset = 0000h)
25h	DAC_MARGIN_HIGH	DAC_MARGIN_HIGH Register (address = 25h) (reset = 0000h)
26h	DAC_MARGIN_LOW	DAC_MARGIN_LOW Register (address = 26h) (reset = 0000h)
01h	PMBUS_OPERATION	PMBUS_OPERATION Register (address = 01h) (reset = 0000h)
78h	PMBUS_STATUS_BYTE	PMBUS_STATUS_BYTE Register (address = 78h) (reset = 0000h)
98h	PMBUS_VERSION	PMBUS_VERSION Register (address = 98h) (reset = 2200h)

Table 17. Access Type Codes

Access Type	Code	Description
Х	Х	Don't care
Read Type		
R	R	Read
Write Type		
W	W	Write
Reset or Default	Value	
-n		Value after reset or the default value

8.6.1 STATUS Register (address = D0h) (reset = 000Ch or 0014h)

Figure 54. STATUS Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
NVM_CRC_ ALARM_ USER	NVM_CRC_ ALARM_ INTERNAL	NVM_ BUSY	DAC_ UPDATE_ BUSY	x						DEVI	CE_ID		VERSI	ON_ID	
R-0h	R-0h	R-0h	R-0h	X-00h									oit: R-0 it: R-14	-	

Table 18. STATUS Register Field Descriptions

Bit	Field	Туре	Reset	Description			
15	NVM_CRC_ALARM_USER	R	0	0 : No CRC error in user NVM bits 1: CRC error in user NVM bits			
14	NVM_CRC_ALARM_INTERNAL	R	0	0 : No CRC error in internal NVM 1: CRC error in internal NVM bits			
13	NVM_BUSY	R	0	0 : NVM write or load completed, Write to DAC registers allowed 1 : NVM write or load in progress, Write to DAC registers not allowed			
12	2 DAC_UPDATE_BUSY		0	0 : DAC outputs updated, Write to DAC registers allowed 1 : DAC outputs update in progress, Write to DAC registers not allowed			
11 - 6	X	Х	00h	Don't care			
5 - 2	DEVICE_ID	R	DAC53401: 0Ch	DAC53401: 0Ch			
1 - 0	VERSION_ID		DAC43401: 14h	DAC43401: 14h			

8.6.2 GENERAL_CONFIG Register (address = D1h) (reset = 01F0h)

Figure 55. GENERAL_CONFIG Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
FUN CON		DEVICE_ LOCK	EN_ PMBUS	CC	DE_STI	EP	SLEW_RATE			DAC	_PDN	REF_EN	DAC_	SPAN	
R/W	7-0h	W-0h	R/W-0h		R/W-0h			R/W	Ī-Fh		R/V	V-2h	R/W-0h	R/V	V-0h

Table 19. GENERAL_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 14	FUNC_CONFIG	R/₩	00	 00 : Generates a triangle wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with slope defined by SLEW_RATE (address D1h) bits. 01: Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with rising slope defined by SLEW_RATE (address D1h) bits and immediate falling edge. 10: Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with falling slope defined by SLEW_RATE (address 26h) code, with falling slope defined by SLEW_RATE (address D1h) bits and immediate rising edge. 11: Generates a square wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with pulse high and low period defined by SLEW_RATE (address D1h) bits.
13	DEVICE_LOCK	W	0	0 : Device not locked 1: Device locked, the device locks all the registers. This bit can be reset (unlock device) by writing 0101 to the DEVICE_UNLOCK_CODE bits (address D3h)
12	EN_PMBUS	R/W	0	0: PMBus mode disabled 1: PMBus mode enabled



Table 19. GENERAL_CONFIG Register Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
11 - 9	CODE_STEP	R/W	000	Code step for programmable slew rate control. 000: Code step size = 1 LSB (default) 001: Code step size = 2 LSB 010: Code step size = 3 LSB 011: Code step size = 4 LSB 100: Code step size = 6 LSB 101: Code step size = 8 LSB 110: Code step size = 16 LSB 111: Code step size = 32 LSB
8 - 5	0000: 25.6 µs 0001: 25.6 µs 0010: 25.6 µs 0010: 25.6 µs 0010: 204.8 µs 0100: 204.8 µs 0111: 204.8 µs 0111: 204.8 µs 1000: 1.6384 r 1001: 1.6384 r 1001: 1.6384 r 1011: 1.6384 r 1011: 1.6384 r 1110: 12 µs (p 1110: 8 µs (pe		Slew rate for programmable slew rate control. 0000: 25.6 μ s (per step) 0001: 25.6 μ s × 1.25 (per step) 0010: 25.6 μ s × 1.50 (per step) 0010: 25.6 μ s × 1.75 (per step) 0110: 25.6 μ s × 1.75 (per step) 0100: 204.8 μ s × 1.75 (per step) 0101: 204.8 μ s × 1.25 (per step) 0111: 204.8 μ s × 1.50 (per step) 0111: 204.8 μ s × 1.75 (per step) 1000: 1.6384 ms × 1.25 (per step) 1001: 1.6384 ms × 1.25 (per step) 1010: 1.6384 ms × 1.50 (per step) 1011: 1.6384 ms × 1.75 (per step) 1011: 1.6384 ms × 1.75 (per step) 1101: 4.6384 ms × 1.75 (per step) 1101: 4.6384 ms × 1.75 (per step) 1101: 1.6384 ms × 1.75 (per step)	
4 - 3	DAC_PDN	R/W	10	00: Power up 01: Power down to 10K 10: Power down to high impedance (default) 11: Power down to 10K
2	REF_EN	R/W	0	0: Internal reference disabled, V_{DD} is DAC reference voltage, DAC output range from 0 to V_{DD} . 1: Internal reference enabled, DAC reference = 1.21 V
1 - 0	DAC_SPAN	R/W	00	Only applicable when internal reference is enabled. 00: Reference to V_{OUT} gain 1.5X 01: Reference to V_{OUT} gain 2X 10: Reference to V_{OUT} gain 3X 11: Reference to V_{OUT} gain 4X

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8.6.3 MED_ALARM_CONFIG Register (address = D2h) (reset = 0000h)

15 14 1	3 12 11	10	9	8	7	6	5	4	3	2	1 0			
>	<	MED_ ALARM_ HP	MED_ ALARM_ MP	MED_ ALARM_ LP	RESERVED		MED_ALARM_ DEAD_TIME		PULSE_ OFF_TIME		PULSE_ ON_TIME			
X-(X-0h W-0h W-0h				RESE	RVED	W-0h	W-0h		\overline{W} -0h \overline{W} -0				
Table 20. MED_ALARM_CONFIG Register Field Descriptions														
Bit	Field			Туре	Reset	Description								
15 - 11	Х			Х	00h	Don't care								
10	MED_AL/	ARM_HP	W	0		medical alarm			enera	ated				
9	MED_AL/	ARM_MP	W	0	0: No medical alarm waveform generated 1: Medium priority medical alarm waveform generated									
8	MED_AL/	ARM_LP	W	0	0: No medical alarm waveform generated 1: Low priority medical alarm waveform generated									
7 - 6	RESERV	ED		Reserved	0	RESERVED								
5 - 4	INTERBURST_TIME			W	00	00: 2.5 01: 2.9 10: 3.3	High priority alarm Medium priority alarm Low priority 00: 2.55 sec Low priority 00: 16 sec 11: 2.96 sec 00: 2.60 sec 01: 16 sec 10: 3.38 sec 01: 3.06 sec 10: 16 sec 11: 3.80 sec 10: 3.52 sec 11: 16 sec 11: 4.00 sec 11: 4.00 sec 11: 16 sec				1: 16 sec 0: 16 sec			
3 - 2	PULSE_0	OFF_TIME		W	00	High p 00: 15 01: 36 10: 58 11: 80	msec msec	alarm 00: 4 01: 6 10: 8	um priority 0 msec 0 msec 0 msec 0 msec 00 msec	0 0 1	ow priority alarm 0: 40 msec 1: 60 msec 0: 80 msec 1: 100 msec			
1 - 0	PULSE_0	ON_TIME		W	00	00: 80 01: 10: 10: 120	riority alarm msec 3 msec 6 msec 0 msec	alarm 00: 1 01: 1 10: 1	um priority 30 msec 53 msec 76 msec 00 msec	0 0 1	ow priority alarm 0: 130 msec 1: 153 msec 0: 176 msec 1: 200 msec			

Figure 56. MED_ALARM_CONFIG Register



8.6.4 TRIGGER Register (address = D3h) (reset = 0008h)

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
DEV	ICE_UNL	OCK_C	ODE	×	K	DEVICE_ CONFIG_ RESET	START_ FUNC_ GEN	PMBUS_ MARGIN_ HIGH	PMBUS_ MARGIN_ LOW	NVM_ RELOAD	NVM_ PROG		SW_R	ESET	
	<u></u> -W-	0h		X	(W-0h	W-0h	R/W-0h	R/W-0h	W-0h	W-0h		W-	-8h	

Figure 57. TRIGGER Register

Table 21. TRIGGER Register Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 12	DEVICE_UNLOCK_CODE	W	0000	Write 0101 to unlock the device to bypass DEVICE_LOCK bit.
11 - 10	x	Х	0h	Don't care
9	DEVICE_CONFIG_RESET	W	0	0: Device configuration reset not initiated 1: Device configuration reset initiated. All registers loaded with factory reset values.
8	START_FUNC_GEN	\overline{W}	0	0: Continuous waveform generation mode disabled 1: Continuous waveform generation mode enabled, device generates continuous waveform based on FUNC_CONFIG (D1h), MARGIN_LOW (address 18h), and SLEW_RATE (address D1h) bits.
7	PMBUS_MARGIN_HIGH	R/W	0	0: PMBus margin high command not initiated 1: PMBus margin high command initiated, DAC output margins high to MARGIN_HIGH code (address 25h). This bit automatically resets to 0 after the DAC code reaches MARGIN_HIGH value.
6	PMBUS_MARGIN_LOW	R/W	0	0: PMBus margin low command not initiated 1: PMBus margin low command initiated, DAC output margins low to MARGIN_LOW code (address 26h). This bit automatically resets to 0 after the DAC code reaches MARGIN_LOW value.
5	NVM_RELOAD	W	0	0: NVM reload not initiated 1: NVM reload initiated, applicable DAC registers loaded with corresponding NVM. NVM_BUSY bit set to 1 which this operation is in progress This is a self-resetting bit.
4	NVM_PROG	W	0	0: NVM write not initiated 1: NVM write initiated, NVM corresponding to applicable DAC registers loaded with existing register settings. NVM_BUSY bit set to 1 which this operation is in progress. This is a self-resetting bit.
3 - 0	SW_RESET	W	1000	1000: Software reset not initiated 1010: Software reset initiated, DAC registers loaded with corresponding NVMs, all other registers loaded with default settings.

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8.6.5 DAC_DATA Register (address = 21h) (reset = 0000h)

Figure 58. DAC_DATA Register

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		>	<			0	DAC_DA	TA[9:0] /	DAC_DA	TA[7:0] -	- MSB Le	eft aligned	t			х
ſ		Х-	0h			W-000h									X	-0h

Table 22. DAC_DATA Register Field Descriptions

Bit	Field	Туре	Reset	Description
15-12	x	Х	0h	Don't care
11-2	DAC_DATA[9:0] / DAC_DATA[7:0]	W	000h	Writing to the DAC_DATA register forces the respective DAC channel to update the active register data to the DAC_DATA. Data are in straight binary format and use the following format: DAC53401: { DATA[9:0] } DAC43401: { DATA[7:0], X, X } X = Don't care bits
1-0	x	Х	0h	Don't care

8.6.6 DAC_MARGIN_HIGH Register (address = 25h) (reset = 0000h)

Figure 59. DAC_MARGIN_HIGH Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	>	<			MAR	GIN_HI	GH[9:0] /	MARGIN	I_HIGH[7	:0] – MSI	3 Left alig	gned			Х
	X-	0h			W-000h									X	-0h

Table 23. DAC_MARGIN_HIGH Register Field Descriptions

Bit	Field	Туре	Reset	Description
15-12	Х	Х	0h	Don't care
11-2	MARGIN_HIGH[9:0] / MARGIN_HIGH[7:0] – MSB Left aligned	W	000h	Margin high code for DAC output. Data are in straight binary format and use the following format: DAC53401: { MARGIN_HIGH[[9:0] } DAC43401: { MARGIN_HIGH[[7:0], X, X } X = Don't care bits
1-0	х	Х	0h	Don't care

8.6.7 DAC_MARGIN_LOW Register (address = 26h) (reset = 0000h)

Figure 60. DAC_MARGIN_LOW Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
)	x			MAF	RGIN_LC) [0:9] /	MARGIN	LOW[7:	:0] – MSE	3 Left alig	gned			Х
	Х-	0h												X	-0h

Table 24. DAC_MARGIN_LOW Register Field Descriptions

Bit	Field	Туре	Reset	Description
15-12	X	Х	0h	Don't care
11-2	MARGIN_LOW[9:0] / MARGIN_LOW[7:0] – MSB Left aligned	W	000h	Margin low code for DAC output. Data is in straight binary format and follows the format below: DAC53401: { MARGIN_LOW[[9:0] } DAC43401: { MARGIN_LOW[[7:0], X, X } X = Don't care bits
1-0	Х	Х	0h	Don't care



8.6.8 PMBUS_OPERATION Register (address = 01h) (reset = 0000h)

Figure 61. PMBUS_OPERATION Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		PMB	JS_OPEI	RATION	_CMD						2	X			
	R/W-00h										X-(00h			

Table 25. PMBUS_OPERATION Register Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 8	PMBUS_OPERATION_CMD	R/W	00h	PMBus operation commands 00h: Turn off 80h: Turn on A4h: Margin high, DAC output margins high to MARGIN_HIGH code (address 25h) 94h: Margin Iow, DAC output margins low to MARGIN_LOW code (address 26h)
7 - 0	х	Х	00h	Not applicable

8.6.9 PMBUS_STATUS_BYTE Register (address = 78h) (reset = 0000h)

Figure 62. PMBUS_STATUS_BYTE Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		>	<			CML					Х				
		X-0)0h			R/W-					X-000h				
						0h									

Table 26. PMBUS_STATUS_BYTE Register Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 10	x	Х	00h	Don't care
9	CML	R/W	0	0: No communication Fault 1: PMBus communication fault for timeout, write with incorrect number of clocks, read before write command, and so more; reset this bit by writing 1.
8 - 0	x	Х	000h	Not applicable

8.6.10 PMBUS_VERSION Register (address = 98h) (reset = 2200h)

Figure 63. PMBUS_VERSION Register

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
PMBUS_VERSION							X								
R-22h									X-()0h					

Table 27. PMBUS_VERSION Register Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 8	PMBUS_VERSION	R	22h	PMBus version
7 - 0	x	Х	00h	Not applicable



9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

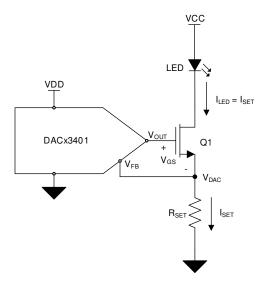
The DACx3401 are buffered, force-sense output, single-channel, DACs that include an NVM and internal reference and are available in a tiny 3 × 3 package. These DACs are designed for general-purpose applications in a wide range of end equipment. Some of the most common applications for these devices are power-supply margining and control, adaptive voltage scaling (AVS), *set-and-forget* LED biasing in mobile projectors, general-purpose function generation, medical alarm generation, and programmable comparator applications (such as smoke detectors, standalone PWM control loops, and offset and gain trimming in precision circuits).

9.2 Typical Applications

This section explains the design details of three primary applications of DACx3401: programmable LED biasing, power-supply margining. and medical alarm generation.

9.2.1 Programmable LED Biasing

LED and laser biasing or driving circuits often require accuracy and stability of the luminosity with respect to variation in temperature, electrical conditions, and physical characteristics. This accuracy and stability are most effectively achieved using a precision DAC, such as the DACx3401. The DACx3401 have additional features, such as the V_{FB} pin that compensates for the gate-to-source voltage of the transistor (V_{GS}) drop and the drift of the MOSFET. The NVM allows the microprocessor to *set-and-forget* the LED biasing value, even during a power cycle. \mathbb{R} 64 shows the circuit diagram for LED biasing.





9.2.1.1 Design Requirements

- DAC output range: 0 V to 2.4 V
- LED current range: 0 mA to 20 mA



Typical Applications (接下页)

9.2.1.2 Detailed Design Procedure

The DAC sets the source current of a MOSFET using the integrated buffer, as shown in 🖺 64. Connect the LED between the power supply and the drain of the MOSFET. This configuration allows the DAC to control or set the amount of current through the LED. The integrated buffer controls the gate-source voltage of the MOSFET inside the feedback loop, thus compensating this drop and corresponding drift due to temperature, current, and ageing of the MOSFET. Calculate the value of the LED current set by the DAC using $\Delta \vec{x}$ 6. In order to generate 0 mA to 20 mA from a 0-V to 2.4-V DAC output range, the value of R_{SET} resistor is 120- Ω . Select the internal reference with a span of 2x. Given a V_{GS} of 1.2 V, the V_{DD} of the DAC must be at least 3.6 V. Select a V_{DD} of 5 V to allow variation of V_{GS} across temperature. When the V_{DD} headroom is a constraint, use a bipolar junction transistor (BJT) in place of the MOSFET. BJTs have much less V_{BE} drop as compared to a V_{GS} of a MOSFET. A MOSFET provides a much better match between the current through the set register and the LED current, as compared to a BJT.

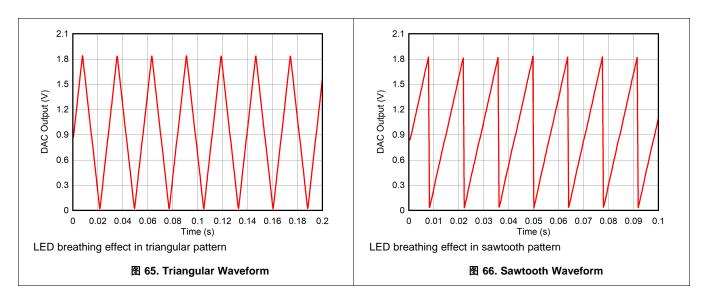
$$I_{SET} = \frac{V_{DAC}}{R_{SET}}$$

(6)

The pseudocode for getting started with an LED biasing application is as follows:

//SYNTAX: WRITE <REGISTER NAME (Hex code)>, <MSB DATA>, <LSB DATA> //Power-up the device, enable internal reference with 2x output span WRITE GENERAL_CONFIG(0xD1), 0x11, 0xE5 //Write DAC code (12-bit aligned) WRITE DAC_DATA(0x21), 0x07, 0xFC //Write settings to the NVM WRITE TRIGGER(0xD3), 0x00, 0x10

9.2.1.3 Application Curves



Typical Applications (接下页)

9.2.2 Power-Supply Margining

A power-supply margining circuit is used to test and trim the output of a power converter. This circuit is used to test a system by margining the power supplies, for adaptive voltage scaling, or to program a desired value at the output. Adjustable power supplies, such as LDOs and DC/DC converters provide a feedback or adjust input that is used to set the desired output. A precision voltage-output DAC is the best choice for controlling the power-supply output linearly. a for shows a control circuit for a switch-mode power supply (SMPS) using DACx3401. Typical applications of power-supply margining are communications equipment, enterprise servers, test and measurement, and general-purpose power-supply modules.

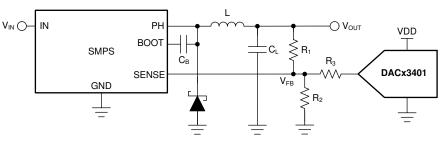


图 67. Power-Supply Margining

9.2.2.1 Design Requirements

- Power supply nominal output: 3.3 V
- Reference voltage of the converter (V_{FB}): 0.6 V
- Margin: ±10% (that is, 2.97 V to 3.63 V)
- DAC output range: 1.8 V
- Nominal current through R₁ and R₂: 100 μA

9.2.2.2 Detailed Design Procedure

The DACx3401 features a Hi-Z power-down mode that is set by default at power-up, unless the device is programmed otherwise using the NVM. When the DAC output is at Hi-Z, the current through R₃ is zero and the SMPS is set at the nominal output voltage of 3.3 V. To have the same nominal condition when the DAC powers up, bring up the device at the same output as V_{FB} (that is 0.6 V). This configuration makes sure there is no current through R₃ even at power-up. Calculate R₁ as (V_{OUT} - V_{FB}) / 100 μ A = 27 kΩ.

To achieve ±10% margin-high and margin-low conditions, the DAC must sink or source additional current through R_1 . Calculate the current from the DAC (I_{MARGIN}) using $\Delta \pm 7$ as 12 μ A.

$$I_{MARGIN} = \left(\frac{V_{OUT} \times (1 + MARGIN) - V_{FB}}{R_1}\right) - I_{NOMINAL}$$

where

- I_{MARGIN} is the margin current sourced or sinked from the DAC.
- MARGIN is the percentage margin value divided by 100.
- $I_{NOMINAL}$ is the nominal current through R_1 and R_2 .

In order to calculate the value of R₃, first decide the DAC output range, and make sure to avoid the codes near zero-scale and full-scale for safe operation in the linear region. A DAC output of 20 mV is a safe consideration as the minimum output, and (1.8 V – 0.6 V – 20 mV = 1.18 V) as the maximum output. When the DAC output is at 20 mV, the power supply goes to margin high, and when the DAC output is at 1.18 V, the power supply goes to margin low. Calculate the value of R₃ using $\Delta \vec{x}$ 8 as 48.3 k Ω . Choose a standard resistor value and adjust the DAC outputs. Choosing R₃ = 47 k Ω makes the DAC margin high code as 1.164 V and the DAC margin low code as 36 mV.

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(7)



Typical Applications (接下页)

$$R_{3} = \frac{\left|V_{DAC} - V_{FB}\right|}{I_{MARGIN}}$$

(8)

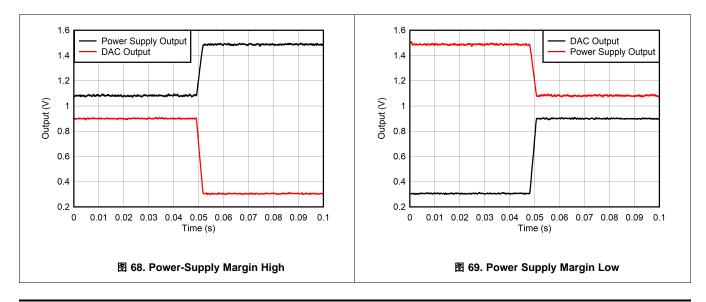
The DACx3401 have a slew rate feature that is used to toggle between margin high, margin low, and nominal outputs with a defined slew rate. See the GENERAL_CONFIG register description for the slew rate setting details.

注 The MARGIN HIGH register value in DACx3401 results in the MARGIN LOW value at the power supply output. Similarly, the MARGIN LOW register value in DACx3401 results in the MARGIN HIGH value at the power-supply output.

The pseudocode for getting started with a power-supply control application is as follows:

//SYNTAX: WRITE <REGISTER NAME (Hex code)>, <MSB DATA>, <LSB DATA> //Write DAC code (12-bit aligned) for nominal output //For a 1.8-V output range, the 10-bit hex code for 0.6 V is 0x0155. With 12bit alignment, it becomes 0x0554 WRITE DAC_DATA(0x21), 0x05, 0x54 //Write DAC code (12-bit aligned) for margin-low output at the power supply //For a 1.8-V output range, the 10-bit hex code for 1.164 V is 0x0296. With 12bit alignment, it becomes 0x0A58 WRITE DAC_MARGIN_HIGH(0x25), 0x0A, 0x58 //Write DAC code (12-bit aligned) for margin-high output at the power supply //For a 1.8-V output range, the 10-bit hex code for 36 mV is 0x14. With 12bit alignment, it becomes 0x50 WRITE DAC_MARGIN_LOW(0x26), 0x00, 0x50 //Powerup the device with enable internal reference with 1.5x output span. This will output the nominal voltage (0.6 V) //CODE_STEP: 2 LSB, SLEW_RATE: 25.6 µs WRITE GENERAL_CONFIG(0xD1), 0x12, 0x14 //Trigger margin-low output at the power supply WRITE TRIGGER(0xD3), 0x00, 0x80 //Trigger margin-high output at the power supply WRITE TRIGGER(0xD3), 0x00, 0x40 //Write back DAC code (12-bit aligned) for nominal output WRITE DAC_DATA(0x21), 0x05, 0x54





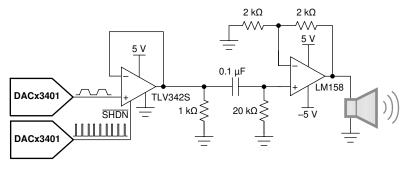


Typical Applications (接下页)

9.2.3 Medical Alarm Generation

All medical devices implementing an alarm system shall comply to IEC60601-1-8 standard for medical alarms (as per IEC60601-1 Ed 3.1). The regulatory tests are done at a system level; therefore, system level acoustics play a major role in the compliance. A medical alarm is a common functional block in many medical devices. A portable implementation is needed that can also be customized to fit mechanical and audio or acoustic requirements. The DACx3401-based design is aimed at providing a programmable, standalone, and robust implementation at a very low cost.

There are three types of alarms with different timing requirements: low priority, medium priority, and high priority. Usually, for easy identification, different timings are employed for different equipment. Medical device manufacturers prefer using their signature melodies within the limits of the standard.





9.2.3.1 Design Requirements

- Alarm envelope rise and fall time: 26 ms
- Alarm pulse frequency: 610 Hz

9.2.3.2 Detailed Design Procedure

Two DACx3401 devices are required: one device to generate the pulse envelope and the burst, and the second device to generate the pulse frequency. As shown in 8 70, mix both these signals together using the TLV342S amplifier with shutdown. Feed the combined signal to a power amplifier, such as the LM158, to drive the speaker. This design provides a gain of 2 at the speaker amplifier. The actual gain required in a system depends on the acoustic output requirements from the speaker. The RC high-pass filter, designed for a cut-off frequency of approximately 80 Hz at the input of LM158, removes the dc component from the signal so that this signal can be applied to the speaker directly. As per the medical alarm standard, the pulse frequency must be above 150 Hz. As a result of the square-wave pulse frequency and the mixing done by TLV342S, the speaker output has multiple harmonics of the fundamental pulse frequency, thus fulfilling the requirement of the medical alarm standard. The DACx3401 provide various options to program the pulse frequency and envelope timings. See the Medical Alarm Generation Mode section for the alarm configuration options. Calculate the frequency of a square wave or pulse frequency using 公式 3. The square wave function has a limited number of frequencies because this function is programmed by the SLEW_RATE bit alone. To get a higher number of frequencies, generate a triangular waveform with comparator mode output. Generate the triangular waveform using 公式 4. Set the DAC output in the comparator mode by fixing the V_{FB} pin to the midscale of the DAC using a resistive voltage divider from V_{DD}. Select V_{DD} as the reference in this case using the GENERAL_CONFIG register.

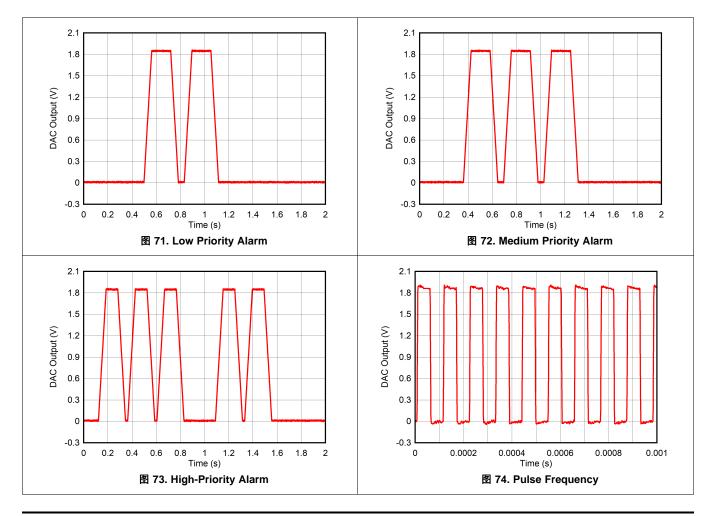


Typical Applications (接下页)

The pseudocode for getting started with a medical alarm application using two DACs is as follows:

//SYNTAX: WRITE <REGISTER NAME (Hex code)>, <MSB DATA>, <LSB DATA> //Power-up the first DAC, enable VDD reference //SLEW_RATE: 1.6384 ms (Square wave frequency: 610 Hz) WRITE GENERAL_CONFIG(0xD1), 0xD1, 0x58 //Set MARGIN_HIGH on the first DAC WRITE DAC_MARGIN_HIGH(0x25), 0x0F, 0xFC //Set MARGIN_LOW on the first DAC WRITE DAC_MARGIN_LOW(0x26), 0x00, 0x00 //Trigger square wave generation on the first DAC WRITE TRIGGER(0xD3), 0x01, 0x00 //Power-up the second DAC, enable VDD reference //CODE_STEP: 8 LSB, SLEW_RATE: 204.8 µs x 1.75 = 358.4 µs (Envelope rise/fall times for fullscale: ~26 ms) WRITE GENERAL_CONFIG(0xD1), 0x1A, 0xE8 //OPTION-1: Configure the second DAC for low-priority alarm with minimum time settings and trigger WRITE MED_ALARM_CONFIG(0xD2), 0x01, 0x00 //OPTION-2: Configure the second DAC for medium-priority alarm with minimum time settings and trigger WRITE MED_ALARM_CONFIG(0xD2), 0x02, 0x00 //OPTION-3: Configure the second DAC for high-priority alarm with minimum time settings and trigger WRITE MED_ALARM_CONFIG(0xD2), 0x04, 0x00 //Set MARGIN_HIGH on the second DAC WRITE DAC_MARGIN_HIGH(0x25), 0x0F, 0xFC //Set MARGIN_LOW on the second DAC WRITE DAC_MARGIN_LOW(0x26), 0x00, 0x00

9.2.3.3 Application Curves





10 Power Supply Recommendations

The DACx3401 family of devices does not require specific supply sequencing. These devices require a single power supply, V_{DD} . Use a 0.1- μ F decoupling capacitor for the V_{DD} pin. Use a bypass capacitor with a value greater than 1.5- μ F for the CAP pin.

11 Layout

11.1 Layout Guidelines

The DACx3401 pin configuration separates the analog, digital, and power pins for an optimized layout. For signal integrity, separate the digital and analog traces, and place decoupling capacitors close to the device pins.

11.2 Layout Example

图 75 shows an example layout drawing with decoupling capacitors and pullup resistors.

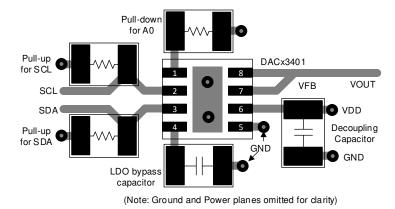


图 75. Layout Example



12 器件和文档支持

12.1 文档支持

12.1.1 相关文档

请参阅如下相关文档:

德州仪器 (TI), 《DAC53401EVM 用户指南》

12.2 相关链接

表 28 列出了快速访问链接。类别包括技术文档、支持和社区资源、工具与软件,以及立即订购快速访问。

		••• -			
器件	产品文件夹	立即订购	技术文档	工具与软件	支持和社区
DAC53401	单击此处	单击此处	单击此处	单击此处	单击此处
DAC43401	单击此处	单击此处	单击此处	单击此处	单击此处

表 28. 相关链接

12.3 接收文档更新通知

要接收文档更新通知,请导航至 ti.com. 上的器件产品文件夹。单击右上角的通知我进行注册,即可每周接收产品 信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

12.4 支持资源

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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12.5 商标

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▲ **ESD** 的损坏小至导致微小的性能降级,大至整个器件故障。精密的集成电路可能更容易受到损坏,这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更,恕不另行通知,且 不会对此文档进行修订。如需获取此数据表的浏览器版本,请查阅左侧的导航栏。



PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	-	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
DAC43401DSGR	ACTIVE	WSON	DSG	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	4341	Samples
DAC43401DSGT	ACTIVE	WSON	DSG	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	4341	Samples
DAC53401DSGR	ACTIVE	WSON	DSG	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	5341	Samples
DAC53401DSGT	ACTIVE	WSON	DSG	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	5341	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

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OTHER QUALIFIED VERSIONS OF DAC43401, DAC53401 :

Automotive : DAC43401-Q1, DAC53401-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nomina Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DAC43401DSGR	WSON	DSG	8	3000	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
DAC43401DSGT	WSON	DSG	8	250	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
DAC53401DSGR	WSON	DSG	8	3000	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
DAC53401DSGT	WSON	DSG	8	250	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

18-Dec-2019



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DAC43401DSGR	WSON	DSG	8	3000	210.0	185.0	35.0
DAC43401DSGT	WSON	DSG	8	250	210.0	185.0	35.0
DAC53401DSGR	WSON	DSG	8	3000	210.0	185.0	35.0
DAC53401DSGT	WSON	DSG	8	250	210.0	185.0	35.0

DSG 8

2 x 2, 0.5 mm pitch

GENERIC PACKAGE VIEW

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





DSG0008A



PACKAGE OUTLINE

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



DSG0008A

EXAMPLE BOARD LAYOUT

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

 Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



DSG0008A

EXAMPLE STENCIL DESIGN

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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